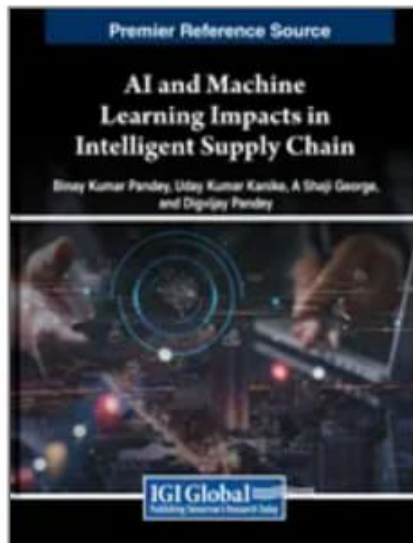




Post-Pandemic Biometric Challenges and Solutions: A Shocker to Supply Chain

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